

<b>Notice of References Cited</b>	Application/Control No. <b>09/889,812</b>	Applicant(s)/Patent Under Reexam <b>Ronaghi</b>	
	Examiner <b>Arun Chakrabarti</b>	Art Unit <b>1634</b>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>
A				
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**FOREIGN PATENT DOCUMENTS**

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N					
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P					
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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	Chou, "Minimizing deletion mutagenesis artifact during taq DNA polymerase PCR by E.coli SSB", Nucleic Acids Research, (1992), Vol. 20, No. 6, page 4371.
V	Stratagene Catalog, "Gene Characterization kits", (1998), page 39.
W	
X	

\* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a). <sup>1</sup> Dates in MM-YYYY format are publication dates. <sup>2</sup> Classifications may be U.S. or foreign.